

Notice of References Cited	Application/Control No. 10/816,822		Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner <i>8/2/05</i> Delma R. Flores Ruiz <i>DFR</i>		Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,661,829 B2	12-2003	Jeon, Heon-su	372/96
*	B	US-2003/0043871 A1	03-2003	Ueda et al.	372/45
*	C	US-6,343,090 B1	01-2002	Yoo et al.	372/96
*	D	US-6,754,245 B2	06-2004	Park et al.	372/50.11
*	E	US-6,778,582 B1	08-2004	Mooradian, Aram	372/97
*	F	US-5,956,362 A	09-1999	Yokogawa et al.	372/46.01
*	G	US-5,822,347 A	10-1998	Yokogawa et al.	372/45.01
*	H	US-2003/0012231 A1	01-2003	Tayebati et al.	372/20
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.